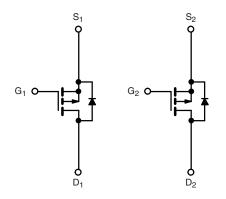


ME6913D-VB Datasheet

Dual P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^d	Q _g (Typ.)	
	0.013 at $V_{GS} = -4.5 \text{ V}$	-7.5		
- 20	0.018 at V _{GS} = - 2.5 V	-6.5	20 nC	
	0.032 at V _{GS} = - 1.8 V	-5.0		



P-Channel MOSFET

P-Channel MOSFET

FEATURES

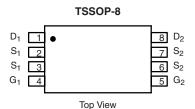
- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

- · Adaptor Switch
- High Current Load Switch
- Notebook



Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 20	V
Gate-Source Voltage		V _{GS}	± 12	v
	T _C = 25 °C		- 7.5	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	1_	- 6.0	
Continuous Diairi Curient (1) = 150 °C)	T _A = 25 °C	I _D	- 5.4 ^{a, b}	
	T _A = 70 °C		- 4.5 ^{a, b}	Α
Pulsed Drain Current		I _{DM}	- 30	A
Outlines Outlines David Divide Outlines	T _C = 25 °C		- 4.1	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 2.1 ^{a, b}	
Avalanche Current	L = 0.1 mH	I _{AS}	- 15	
Single-Pulse Avalanche Energy	L = 0.1 Min	E _{AS}	11.25	mJ
	T _C = 25 °C		5	
Maximum Power Dissipation	T _C = 70 °C		3.2	w
	T _A = 25 °C	P _D	2.5 ^{a, b}	VV
	T _A = 70 °C		1.6 ^{a, b}	
Operating Junction and Storage Temperature Range		T _J , T _{stq}	- 55 to 150	°C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	38	50	°C/W	
Maximum Junction-to-Foot	Steady State	R_{thJF}	20	25	C/VV	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 85 $^{\circ}\text{C/W}.$
- d. Based on $T_C = 25$ °C.

服务热线:400-655-8788

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static		,					
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J			- 14.5			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		2.8		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.4		- 1.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zone Onto Vellana Busin Ones :	1	V _{DS} = - 20 V, V _{GS} = 0 V			- 1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 20 V, V _{GS} = 0 V, T _J = 70 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -5 \text{ V}$	- 20			Α	
	_ ()	V _{GS} = - 4.5 V, I _D = - 7 A		0.013			
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -2.5 \text{ V}, I_D = -6 \text{ A}$		0.018		Ω	
	= = (,	V _{GS} = - 1.8 V, I _D = - 3 A		0.032			
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 9 A		40		S	
Dynamic ^b							
Input Capacitance	C _{iss}			2380			
Output Capacitance	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		340		pF	
Reverse Transfer Capacitance	C _{rss}	30		280			
T. 10 . 0	$Q_g = V_{DS} = -10 \text{ V, V}$	V _{DS} = - 10 V, V _{GS} = - 8 V, I _D = - 5 A		45	70	+	
Total Gate Charge		30 30		20	35		
Gate-Source Charge		V _{DS} = - 10 V, V _{GS} = - 4.5 V, I _D = - 5 A		3.1		nC	
Gate-Drain Charge	Q _{gd}	30 30		8.4			
Gate Resistance	R _q	f = 1 MHz	1.0	4.8	9.6	Ω	
Turn-On Delay Time	t _{d(on)}			7	14		
Rise Time	t _r	$V_{DD} = -10 \text{ V}, R_1 = 2 \Omega$		9	18		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -5 \text{ A}, V_{GEN} = -8 \text{ V}, R_q = 1 \Omega$		108	200	1	
Fall Time	t _f	3		41	80		
Turn-On Delay Time	t _{d(on)}			14	28	ns	
Rise Time	t _r	$V_{DD} = -10 \text{ V, R}_{1} = 2 \Omega$		16	32		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_a = 1 \Omega$		101	200	1	
Fall Time	t _f			40	80		
Drain-Source Body Diode Characteris	stics	1					
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 4.1		
Pulse Diode Forward Current	I _{SM}	-			- 40	A	
Body Diode Voltage	V _{SD}	I _S = - 3 A, V _{GS} = 0 V		- 0.66	- 1.2	٧	
Body Diode Reverse Recovery Time	t _{rr}	3		81	150	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	1		150	300	nC	
Reverse Recovery Fall Time	t _a	$I_F = -2.3 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		43			
Reverse Recovery Rise Time	t _b			38		ns	

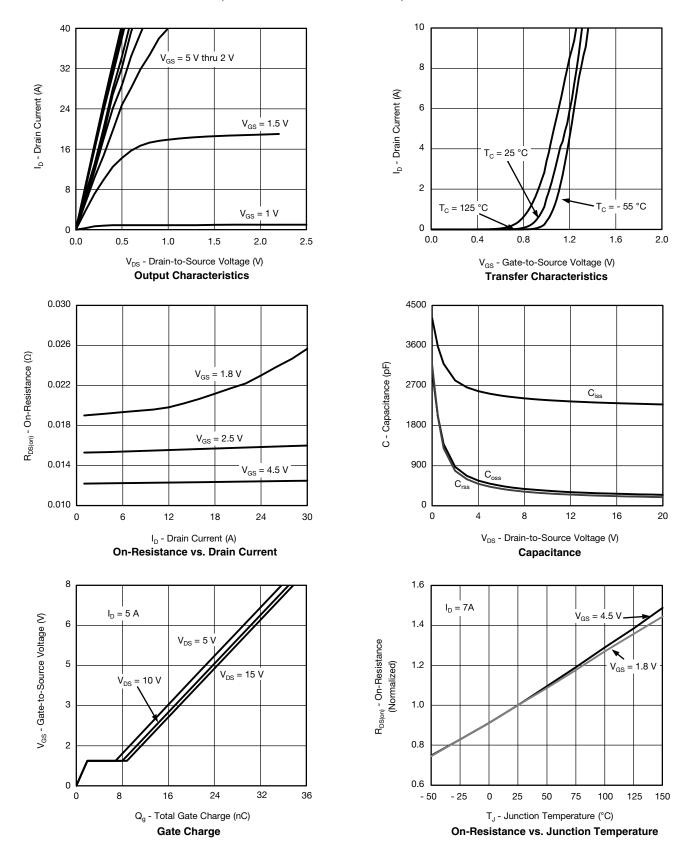
Notes:

2

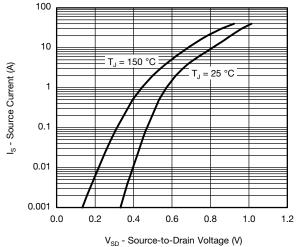
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

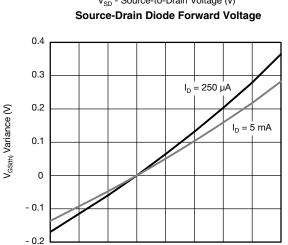
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.











T_J - Temperature (°C)

Threshold Voltage

100

125

150

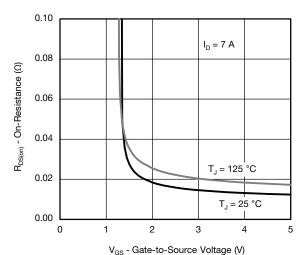
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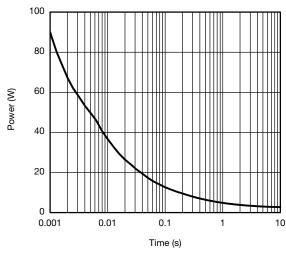
- 25

0

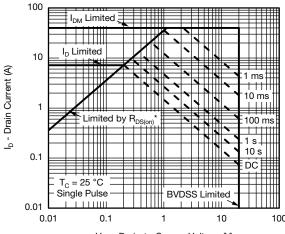
25



On-Resistance vs. Gate-to-Source Voltage



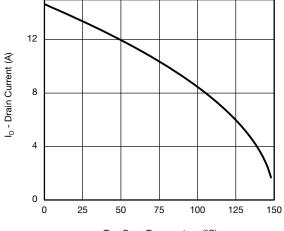
Single Pulse Power, Junction-to-Ambient



 $V_{DS} \text{ - Drain-to-Source Voltage (V)} \\ ^*V_{GS} > minimum \ V_{GS} \text{ at which } R_{DS(on)} \text{ is specified}$

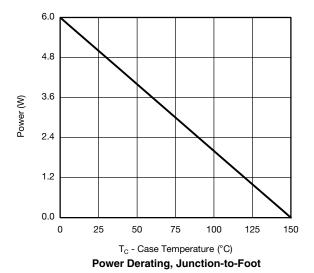
Safe Operating Area

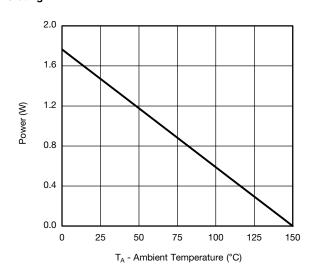




T_C - Case Temperature (°C)

Current Derating*

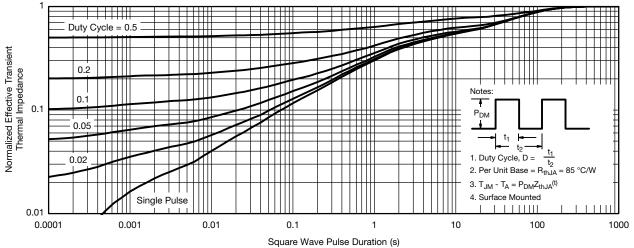




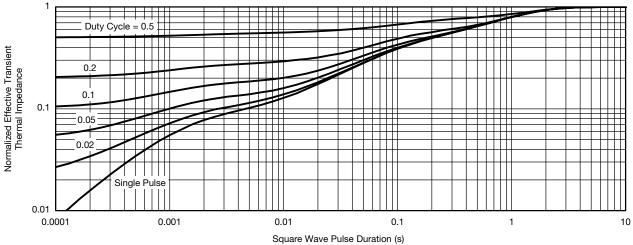
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



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